

41  
Docket No.: 4425-168

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of

LU, YEN-TING

U.S. Patent Application No. 09/919,861

Filed: August 2, 2001



Group Art Unit: 1756

Examiner: YOUNG, CHRISTOPHER G.

1756  
PATENT  
**RECEIVED**  
JAN 26 2004  
TC 1700

For: METHOD FOR REDUCING LINE EDGE ROUGHNESS OF PHOTORESIST

Dear Sir:

Transmitted herewith is an Amendment in the above identified application.

- ☒ No additional fee is required.  
☐ Small entity status of this application has been established.  
☐ Also attached:


The fee has been calculated as shown below:

	NO. OF CLAIMS	HIGHEST PREVIOUSLY PAID FOR	EXTRA CLAIMS	RATE	FEE
Total Claims	33	33	0	x \$ 18 =	\$ 0.00
Independent Claims	3	3	0	x \$ 86 =	\$ 0.00
If multiple claims newly presented, add \$290.00					
Fee for extension of time					
<b>TOTAL FEE DUE</b>					<b>\$ 0.00</b>

- ☐ A credit card authorization form in the amount of \_\_\_\_\_ is attached
- ☒ The Commissioner is hereby authorized to charge payment of any fees associated with this communication or credit any overpayment, to Deposit Account No. 07-1337, including any filing fees under 37 CFR 1.16 for presentation of extra claims and any patent application processing fees under 37 CFR 1.17.

Respectfully submitted,

**LOWE HAUPTMAN GILMAN & BERNER, LLP**

  
Benjamin J. Hauptman  
Registration No.: 29,310

1700 Diagonal Road, Suite 300  
Alexandria, Virginia 22314  
(703) 684-1111  
(703) 518-5499 Facsimile  
Date: January 21, 2004  
BJH/jk